10/534696

JC20 Rec'd PCT/PTO 1 3 MAY 2005

#### IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Mete E. ERDEMGIL

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed May 13, 2005

Examiner

METHOD FOR REDUCING THE LIQUEFACTION POTENTIAL OF FOUNDATION SOILS

# INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

May 13, 2005

Sir:

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Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

#### I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

#### II. COPIES

- Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

10/534696 ket No. 3501-1098

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III.			YLANA least		OF THE RELEVANCE
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	b.		DOCUM	ENTS	NOT IN THE ENGLISH LANGUAGE
			paten	ts,	se explanation of the relevance of all publications, or other information listed not in the English language is as follows:
	c.	$\boxtimes$	FOREI	GN SE	EARCH REPORT OR ACTION
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	d.		OTHER		
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If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.					
					Respectfully submitted,
					YOUNG & THOMPSON
					Eric Jensen, Reg. No. 37,855 745 South 23 <sup>rd</sup> Street Arlington, VA 22202 Telephone (703) 521-2297 Telefax (703) 685-0573 (703) 979-4709
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Other:\_\_\_

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### INFORMATION DISCLOSURE CITATION IN AN APPLICATION

Attorney Docket No.: 3501-1098

(Use several sheets if necessary)

Applicant:

Mete E. ERDEMGIL

Filing Date:

Group Art Unit:

## May 13, 2005 **U.S. PATENT DOCUMENTS Document Number** Date Name Class Subclass Filing date Examiner (if appropriate) Initial 2,627,169 2/3/1953 **POULTER** 4,832,533 5/23/1989 RINGESTEN FOREIGN PATENT DOCUMENTS Class Translation Subclass **Document Number** Date Country Examiner Initial Yes EP 0 773 328 5/14/1997 **EUROPE** EP 0 851 064 7/1/1998 **EUROPE** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) **EXAMINER:** DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

<sup>\*</sup> English language abstract provided for the Examiner's convenience